## Applicant(s)/Patent Under Application/Control No. Reexamination 09/721,096 CHRISTENSEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Yelena G. Gakh, Ph.D. 1743 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY Α US-US-В US-С US-D US-Ε F US-US-G US-Н USŧ US-J US-Κ US-L

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	CA 1059744 A	08-1979	Canada	BANSBACH et al.	C09K 07/02
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## **NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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